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Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic			Symbol	Value	Units
Drain-Source Voltage			V_{DSS}	20	V
Gate-Source Voltage			V_{GSS}	±12	V
Continuous Drain Current (Note 6) V_{GS} = 4.5V	Steady State	T_A = +25°C T_A = +70°C	I_D	10.5 8.4	A
	t<10s	T_A = +25°C T_A = +70°C	I_D	13.4 10.7	A
Continuous Drain Current (Note 6) V_{GS} = 2.5V	Steady State	T_A = +25°C T_A = +70°C	I_D	8.5 6.8	A
	t<10s	T_A = +25°C T_A = +70°C	I_D	10.9 8.7	A
Maximum Continuous Body Diode Forward Current (Note 6)			I_S	6.0	A
Pulsed Drain Current (10µs pulse, duty cycle = 1%)			I_{DM}	45.0	A
Avalanche Current (Note 7) L = 0.1mH			I_{AS}	7.8	A
Avalanche Energy (Note 7) L = 0.1mH			E_{AS}	3.0	mJ

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 5)		P_D	1.5	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{\theta JA}$	82	°C/W
	t<10s		48	°C/W
Total Power Dissipation (Note 6)		P_D	2.0	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{\theta JA}$	60	°C/W
	t<10s		37	°C/W
Thermal Resistance, Junction to Case		$R_{\theta JC}$	6.4	°C/W
Operating and Storage Temperature Range		T_J, T_{STG}	-55 to 150	°C

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV_{DSS}	20	-	-	V	V_{GS} = 0V, I_D = 250µA
Zero Gate Voltage Drain Current	I_{DSS}	-	-	1.0	µA	V_{DS} = 20V, V_{GS} = 0V
Gate-Source Leakage	I_{GSS}	-	-	±100	nA	V_{GS} = ±12V, V_{DS} = 0V
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	$V_{GS(th)}$	0.7	—	1.3	V	V_{DS} = V_{GS}, I_D = 250µA
Static Drain-Source On-Resistance	$R_{DS(ON)}$	—	—	12.5	mΩ	V_{GS} = 4.5V, I_D = 9.4A
		—	—	19		V_{GS} = 2.5V, I_D = 8.3A
Diode Forward Voltage	V_{SD}	—	0.7	1.3	V	V_{GS} = 0V, I_S = 1.3A
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C_{iss}	—	1,000	—	pF	V_{DS} = 10V, V_{GS} = 0V, f = 1.0MHz
Output Capacitance	C_{oss}	—	166	—		
Reverse Transfer Capacitance	C_{rss}	—	158	—		
Gate Resistance	R_g	—	1.51	3.2	Ω	V_{DS} = 0V, V_{GS} = 0V, f = 1MHz
Total Gate Charge (V_{GS} = 2.5V)	Q_g	—	7.0	—	nC	V_{DS} = 10V, I_D = 9.4A
Total Gate Charge (V_{GS} = 4.5V)	Q_g	—	11.6	—		
Gate-Source Charge	Q_{gs}	—	2.7	—		
Gate-Drain Charge	Q_{gd}	—	3.4	—		
Turn-On Delay Time	$t_{D(on)}$	—	11.67	—	ns	V_{GS} = 4.5V, V_{DS} = 10V, R_G = 6Ω , I_D = 1A
Turn-On Rise Time	t_r	—	12.49	—		
Turn-Off Delay Time	$t_{D(off)}$	—	35.89	—		
Turn-Off Fall Time	t_f	—	12.33	—		
Reverse Recovery Time	T_{rr}	—	10.8	—	ns	I_F = 12A, di/dt = 500A/µs
Reverse Recovery Charge	Q_{rr}	—	5.8	—	nC	

Notes:
5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
7. I_{AS} and E_{AS} rating are based on low frequency and duty cycles to keep T_J = 25°C.
8. Short duration pulse test used to minimize self-heating effect.
9. Guaranteed by design. Not subject to product testing.

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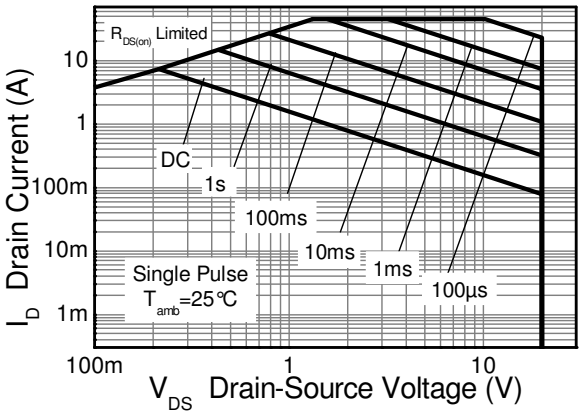
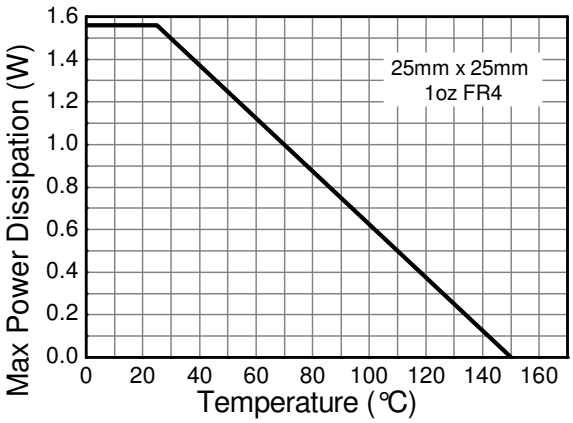
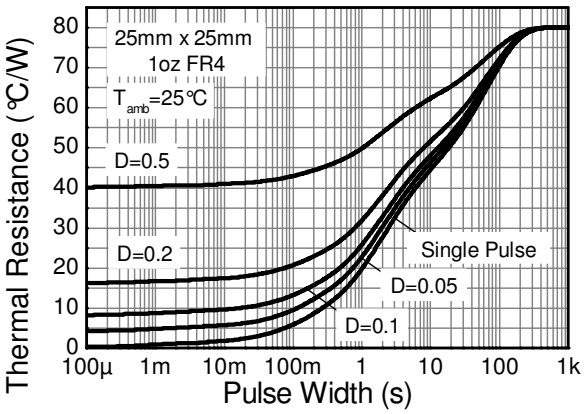
Thermal Characteristics



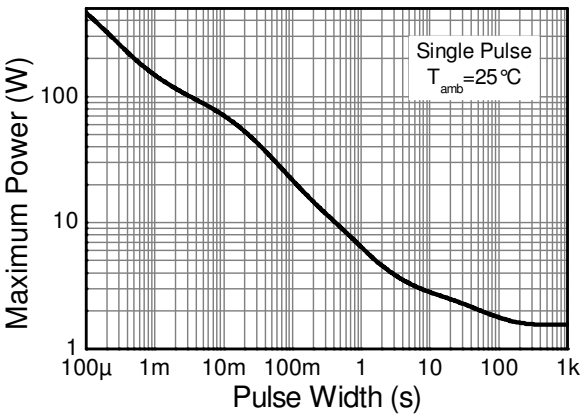
Safe Operating Area



Derating Curve



Transient Thermal Impedance



Pulse Power Dissipation

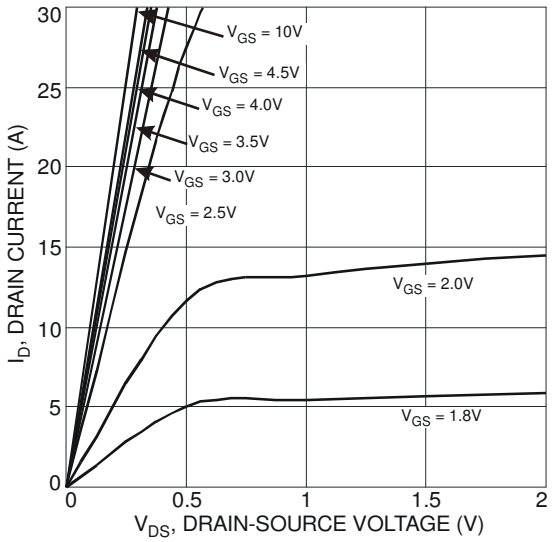


Fig. 1 Typical Output Characteristic

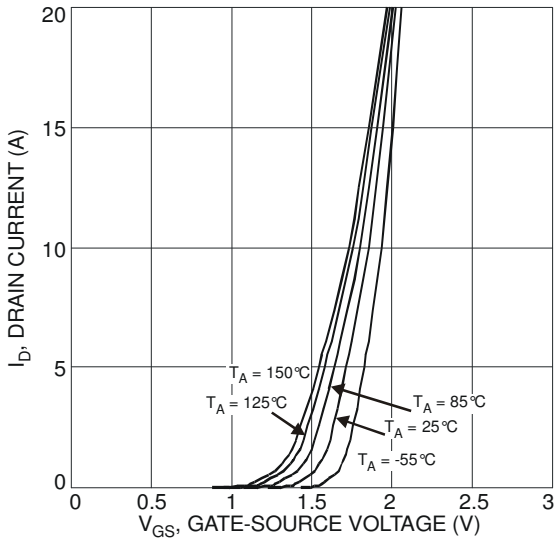


Fig. 2 Typical Transfer Characteristic

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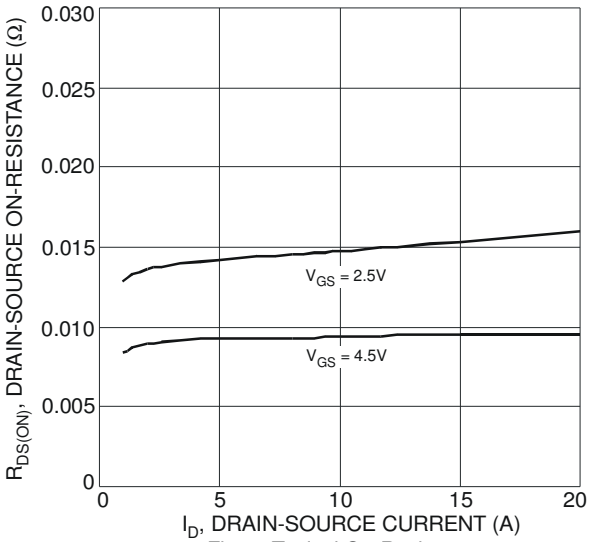

Fig. 3 Typical On-Resistance vs. Drain Current and Gate Voltage

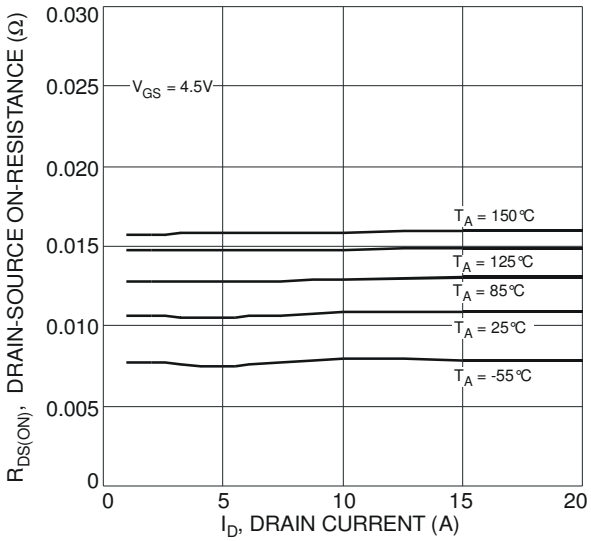

Fig. 4 Typical On-Resistance vs. Drain Current and Temperature

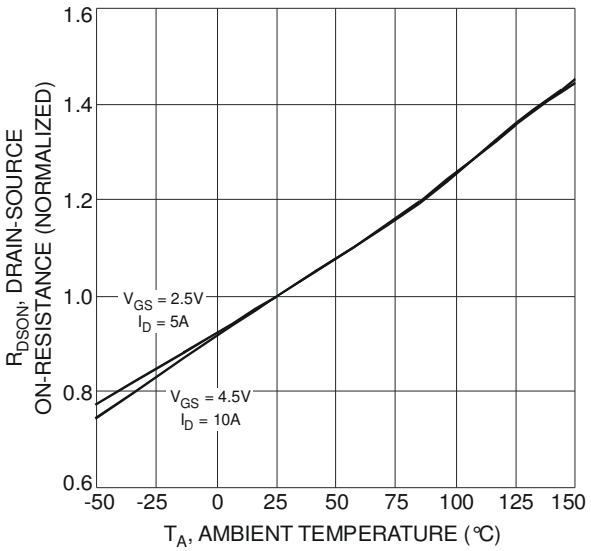

Fig. 5 On-Resistance Variation with Temperature

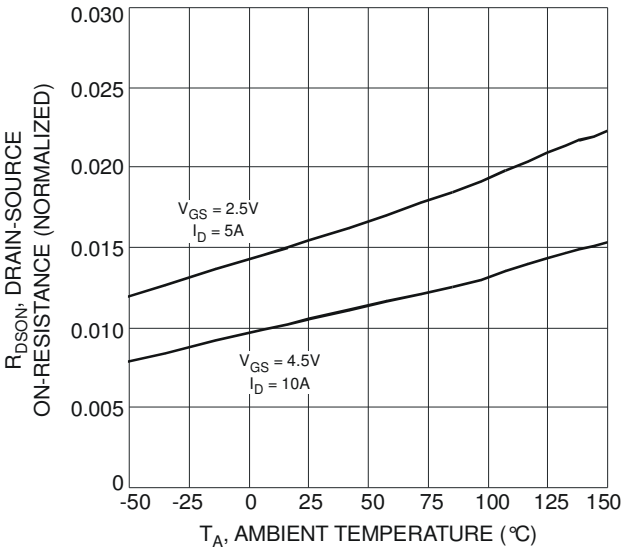

Fig. 6 On-Resistance Variation with Temperature

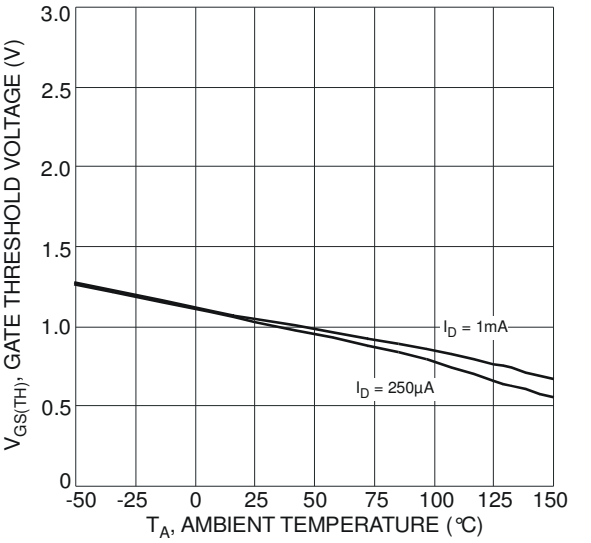

Fig. 7 Gate Threshold Variation vs. Ambient Temperature

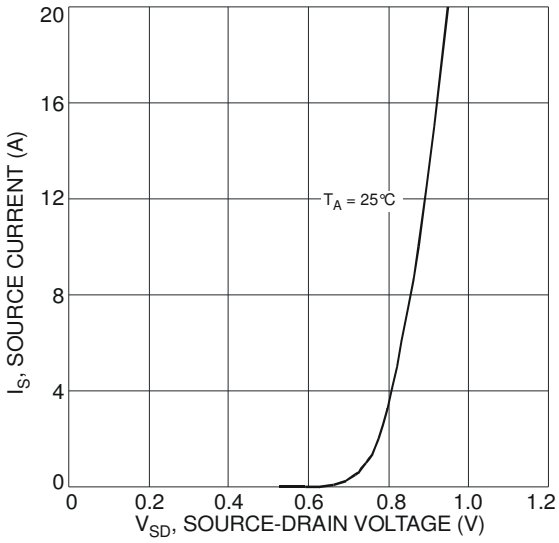

Fig. 8 Diode Forward Voltage vs. Current

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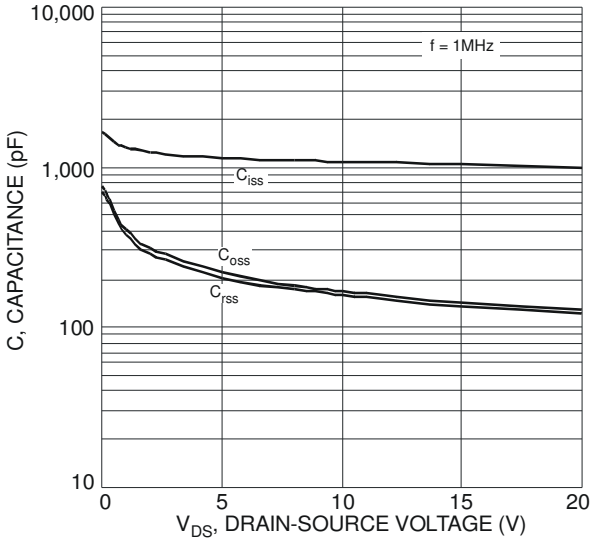

Fig. 9 Typical Total Capacitance

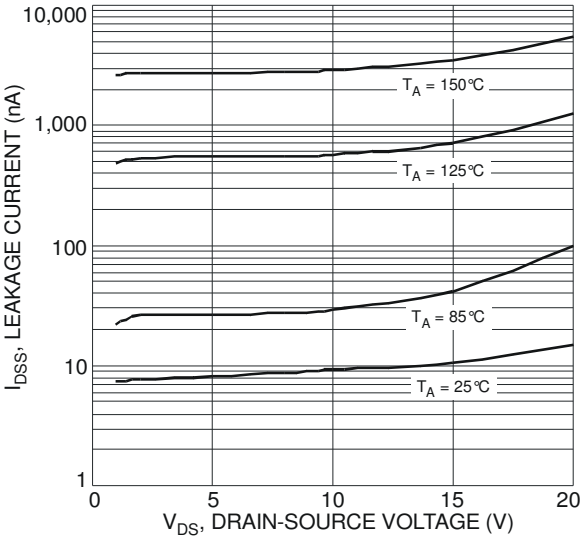

Fig. 10 Typical Leakage Current vs. Drain-Source Voltage

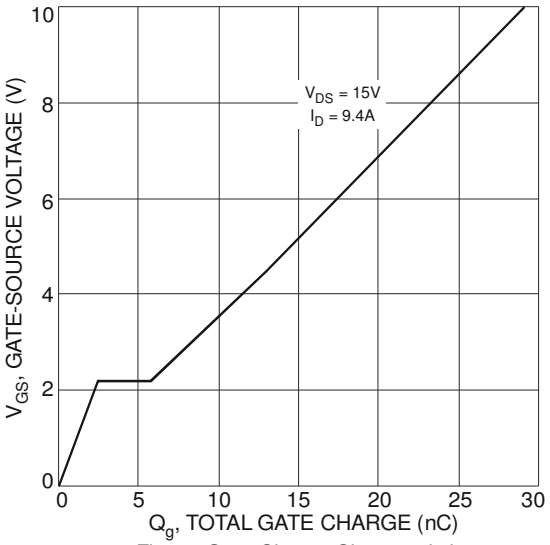

Fig. 11 Gate-Charge Characteristics

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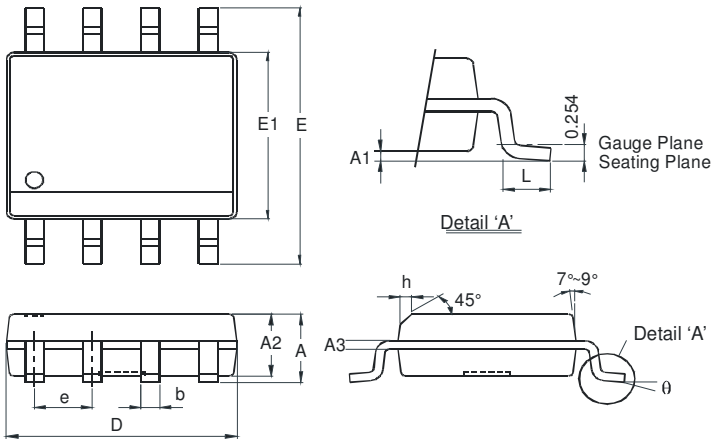
Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

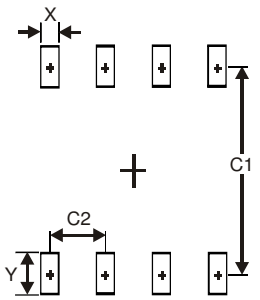


SO-8		
Dim	**Min**	**Max**
A	-	1.75
A1	0.10	0.20
A2	1.30	1.50
A3	0.15	0.25
b	0.3	0.5
D	4.85	4.95
E	5.90	6.10
E1	3.85	3.95
e	1.27 Typ	
h	-	0.35
L	0.62	0.82
θ	0°	8°
All Dimensions in mm		

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.

SO-8



Dimensions	Value (in mm)
X	0.60
Y	1.55
C1	5.4
C2	1.27

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